

<b>Notice of References Cited</b>	Application/Control No. 10/789,757	Applicant(s)/Patent Under Reexamination ALVAREZ ET AL.	
	Examiner Dao L. Phan	Art Unit 3662	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,697,622	02-2004	Ishikawa et al.	455/434
*	B	US-6,888,880	05-2005	Lee et al.	375/149
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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